

0.1 : Hynix Change

0.2 : Burst Mode Single Write Mode Correction



# HY57V28420HC(L)T

## 4Banks x 8M x 4bits Synchronous DRAM

### DESCRIPTION

The Hynix HY57V28420HC(L)T is a 134,217,728bit CMOS Synchronous DRAM, ideally suited for the main memory applications which require large memory density and high bandwidth. HY57V28420HC(L)T is organized as 4banks of 8,388,608x4.

HY57V28420HC(L)T is offering fully synchronous operation referenced to a positive edge of the clock. All inputs and outputs are synchronized with the rising edge of the clock input. The data paths are internally pipelined to achieve very high bandwidth. All input and output voltage levels are compatible with LVTTTL.

Programmable options include the length of pipeline (Read latency of 2 or 3), the number of consecutive read or write cycles initiated by a single control command (Burst length of 1,2,4,8 or full page), and the burst count sequence(sequential or interleave). A burst of read or write cycles in progress can be terminated by a burst terminate command or can be interrupted and replaced by a new burst read or write command on any cycle. (This pipelined design is not restricted by a `2N` rule.)

### FEATURES

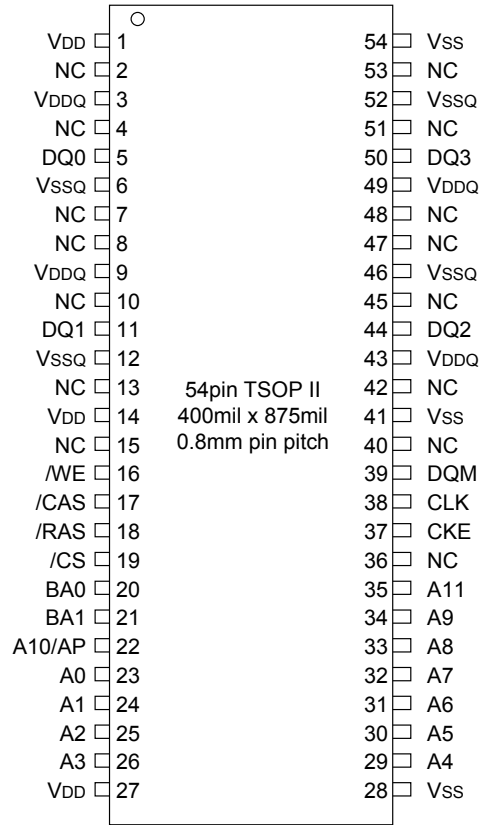
- Single 3.3±0.3V power supply
- All device pins are compatible with LVTTTL interface
- JEDEC standard 400mil 54pin TSOP-II with 0.8mm of pin pitch
- All inputs and outputs referenced to positive edge of system clock
- Data mask function by DQM
- Internal four banks operation
- Auto refresh and self refresh
- 4096 refresh cycles / 64ms
- Programmable Burst Length and Burst Type
  - 1, 2, 4, 8 or Full Page for Sequential Burst
  - 1, 2, 4 or 8 for Interleave Burst
- Programmable  $\overline{\text{CAS}}$  Latency ; 2, 3 Clocks

### ORDERING INFORMATION

Part No.	Clock Frequency	Power	Organization	Interface	Package
HY57V28420HCT-6	166MHz	Normal	4Banks x 8Mbits x 4	LVTTTL	400mil 54pin TSOP II
HY57V28420HCT-K	133MHz				
HY57V28420HCT-H	133MHz				
HY57V28420HCT-8	125MHz				
HY57V28420HCT-P	100MHz				
HY57V28420HCT-S	100MHz				
HY57V28420HCLT-6	166MHz	Low power			
HY57V28420HCLT-K	133MHz				
HY57V28420HCLT-H	133MHz				
HY57V28420HCLT-8	125MHz				
HY57V28420HCLT-P	100MHz				
HY57V28420HCLT-S	100MHz				

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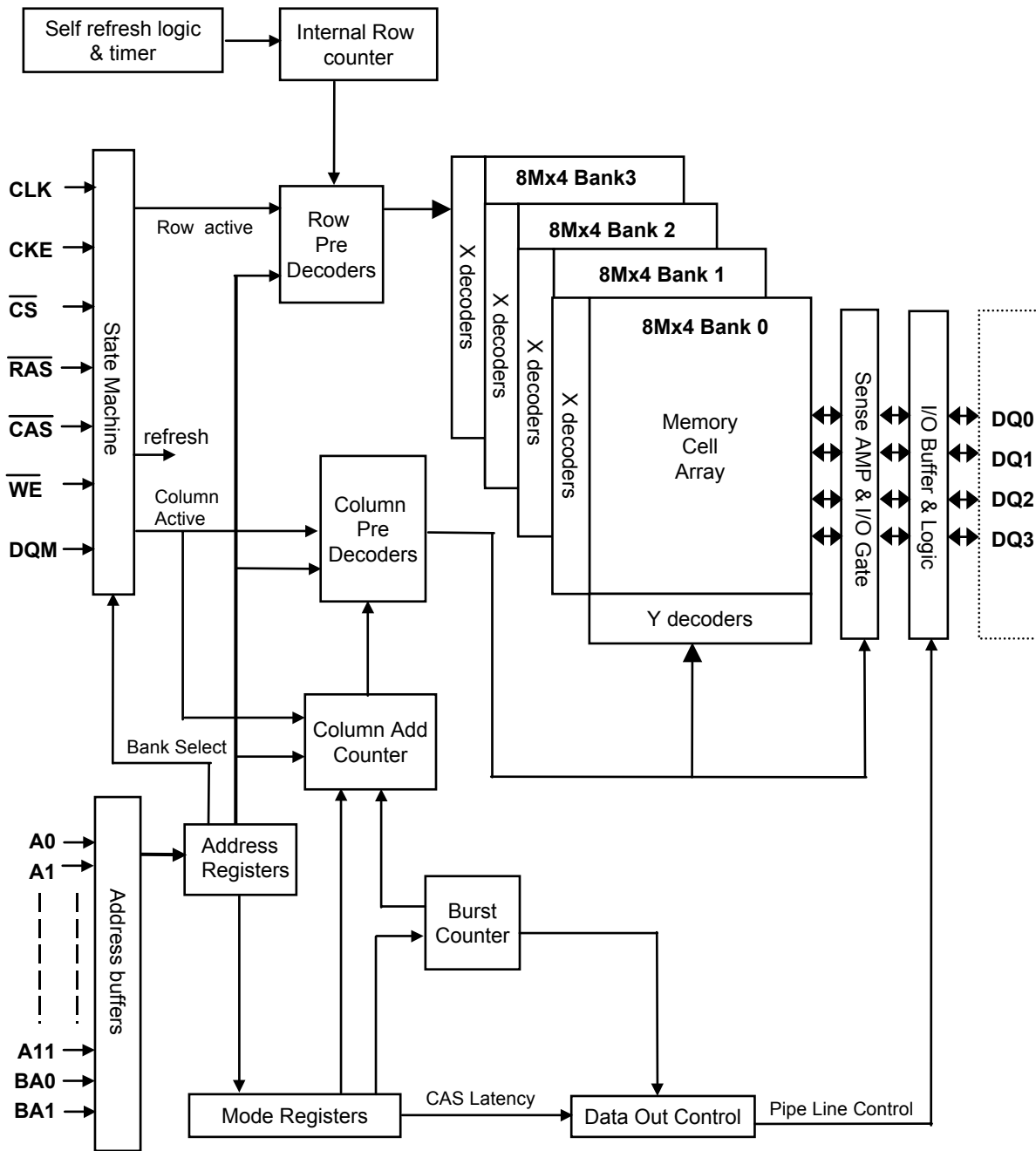
Rev. 0.2/Aug. 01

**PIN CONFIGURATION**

**PIN DESCRIPTION**

PIN	PIN NAME	DESCRIPTION
CLK	Clock	The system clock input. All other inputs are registered to the SDRAM on the rising edge of CLK
CKE	Clock Enable	Controls internal clock signal and when deactivated, the SDRAM will be one of the states among power down, suspend or self refresh
$\overline{CS}$	Chip Select	Enables or disables all inputs except CLK, CKE and DQM
BA0, BA1	Bank Address	Selects bank to be activated during $\overline{RAS}$ activity Selects bank to be read/written during $\overline{CAS}$ activity
A0 ~ A11	Address	Row Address : RA0 ~ RA11, Column Address : CA0 ~ CA9, CA11 Auto-precharge flag : A10
$\overline{RAS}$ , $\overline{CAS}$ , $\overline{WE}$	Row Address Strobe, Column Address Strobe, Write Enable	$\overline{RAS}$ , $\overline{CAS}$ and $\overline{WE}$ define the operation Refer function truth table for details
DQM	Data Input/Output Mask	Controls output buffers in read mode and masks input data in write mode
DQ0 ~ DQ3	Data Input/Output	Multiplexed data input / output pin
VDD/VSS	Power Supply/Ground	Power supply for internal circuits and input buffers
VDDQ/VSSQ	Data Output Power/Ground	Power supply for output buffers
NC	No Connection	No connection

**FUNCTIONAL BLOCK DIAGRAM**

8Mbit x 4banks x 4 I/O Synchronous DRAM



**ABSOLUTE MAXIMUM RATINGS**

Parameter	Symbol	Rating	Unit
Ambient Temperature	TA	0 ~ 70	°C
Storage Temperature	TSTG	-55 ~ 125	°C
Voltage on Any Pin relative to VSS	VIN, VOUT	-1.0 ~ 4.6	V
Voltage on VDD relative to VSS	VDD, VDDQ	-1.0 ~ 4.6	V
Short Circuit Output Current	IOS	50	mA
Power Dissipation	PD	1	W
Soldering Temperature · Time	TSOLDER	260 · 10	°C · Sec

**Note :** Operation at above absolute maximum rating can adversely affect device reliability.

**DC OPERATING CONDITION** (TA=0 to 70°C)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Power Supply Voltage	VDD, VDDQ	3.0	3.3	3.6	V	1
Input High voltage	VIH	2.0	3.0	VDDQ + 0.3	V	1,2
Input Low voltage	VIL	-0.3	0	0.8	V	1,3

**Note :**

1. All voltages are referenced to VSS = 0V
2. VIH(max) is acceptable 5.6V AC pulse width with <=3ns of duration.
3. VIL(min) is acceptable -2.0V AC pulse width with <=3ns of duration.

**AC OPERATING TEST CONDITION** (TA=0 to 70°C, VDD=3.3±0.3V, VSS=0V)

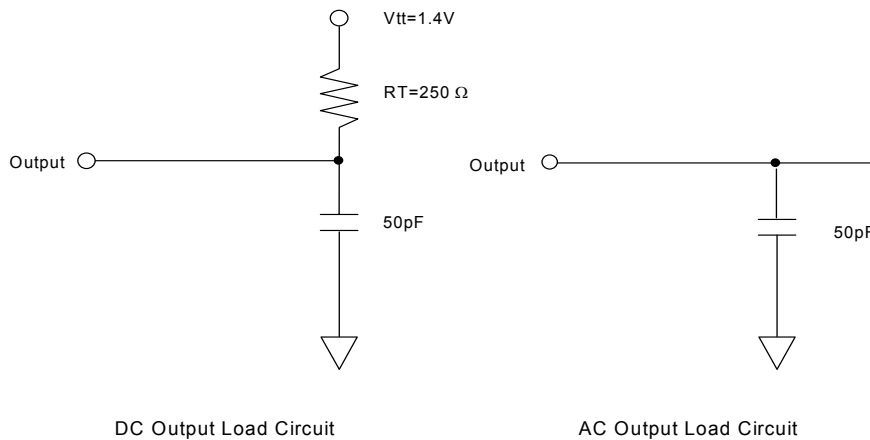
Parameter	Symbol	Value	Unit	Note
AC Input High / Low Level Voltage	VIH / VIL	2.4/0.4	V	
Input Timing Measurement Reference Level Voltage	Vtrip	1.4	V	
Input Rise / Fall Time	tR / tF	1	ns	
Output Timing Measurement Reference Level Voltage	Voutref	1.4	V	
Output Load Capacitance for Access Time Measurement	CL	50	pF	1

**Note :**

1. Output load to measure access times is equivalent to two TTL gates and one capacitor (50pF). For details, refer to AC/DC output load circuit

**CAPACITANCE** (TA=25°C, f=1MHz)

Parameter	Pin	Symbol	-6/K/H		-8/P/S		Unit
			Min.	Max.	Min.	Max.	
Input Capacitance	CLK	CI1	2.5	3.5	2.5	4	pF
	A0 ~ A11, BA0, BA1, CKE, CS, RAS, CAS, WE, DQM	CI2	2.5	3.8	2.5	5	pF
Data Input / Output Capacitance	DQ0 ~ DQ3	CI/O	4	6.5	4	6.5	pF

**OUTPUT LOAD CIRCUIT**

**DC CHARACTERISTICS I** (TA=0 to 70°C, VDD=3.3±0.3V)

Parameter	Symbol	Min.	Max	Unit	Note
Input Leakage Current	ILI	-1	1	uA	1
Output Leakage Current	ILO	-1	1	uA	2
Output High Voltage	VOH	2.4	-	V	IOH = -2mA
Output Low Voltage	VOL	-	0.4	V	IOL = +2mA

**Note :**

1. VIN = 0 to 3.6V, All other pins are not under test = 0V
2. DOUT is disabled, VOUT=0 to 3.6V

**DC CHARACTERISTICS II** ( $T_A=0$  to  $70^\circ\text{C}$ ,  $V_{DD}=3.3\pm 0.3\text{V}$ ,  $V_{SS}=0\text{V}$ )

Parameter	Symbol	Test Condition	Speed						Unit	Note	
			-6	-K	-H	-8	-P	-S			
Operating Current	IDD1	Burst length=1, One bank active $t_{RC} \geq t_{RC}(\text{min})$ , $I_{OL}=0\text{mA}$	120	110	110	110	100	100	mA	1	
Precharge Standby Current in Power Down Mode	IDD2P	$\text{CKE} \leq V_{IL}(\text{max})$ , $t_{CK} = 15\text{ns}$	2						mA		
	IDD2PS	$\text{CKE} \leq V_{IL}(\text{max})$ , $t_{CK} = \infty$	1								
Precharge Standby Current in Non Power Down Mode	IDD2N	$\text{CKE} \geq V_{IH}(\text{min})$ , $\overline{\text{CS}} \geq V_{IH}(\text{min})$ , $t_{CK} = 15\text{ns}$ Input signals are changed one time during 30ns. All other pins $\geq V_{DD}-0.2\text{V}$ or $\leq 0.2\text{V}$	15						mA		
	IDD2NS	$\text{CKE} \geq V_{IH}(\text{min})$ , $t_{CK} = \infty$ Input signals are stable.	15								
Active Standby Current in Power Down Mode	IDD3P	$\text{CKE} \leq V_{IL}(\text{max})$ , $t_{CK} = 15\text{ns}$	5						mA		
	IDD3PS	$\text{CKE} \leq V_{IL}(\text{max})$ , $t_{CK} = \infty$	5								
Active Standby Current in Non Power Down Mode	IDD3N	$\text{CKE} \geq V_{IH}(\text{min})$ , $\overline{\text{CS}} \geq V_{IH}(\text{min})$ , $t_{CK} = 15\text{ns}$ Input signals are changed one time during 30ns. All other pins $\geq V_{DD}-0.2\text{V}$ or $\leq 0.2\text{V}$	30						mA		
	IDD3NS	$\text{CKE} \geq V_{IH}(\text{min})$ , $t_{CK} = \infty$ Input signals are stable.	20								
Burst Mode Operating Current	IDD4	$t_{CK} \geq t_{CK}(\text{min})$ , $I_{OL}=0\text{mA}$ All banks active	CL=3	140	120	120	120	110	110	mA	1
			CL=2	150	130	130	130	110	110		
Auto Refresh Current	IDD5	$t_{RRC} \geq t_{RRC}(\text{min})$ , All banks active	240	220	220	200	200	200	mA	2	
Self Refresh Current	IDD6	$\text{CKE} \leq 0.2\text{V}$	2						mA	3	
			800						uA	4	

**Note :**

- 1.IDD1 and IDD4 depend on output loading and cycle rates. Specified values are measured with the output open.
- 2.Min. of  $t_{RRC}$  (Refresh  $\overline{\text{RAS}}$  cycle time) is applied to HY57V28420HC(L)T-6/K/H/8/P/S which are listed on AC characteristic II.
- 3.HY57V28420HCT-6/K/H/8/P/S
- 4.HY57V28420HCLT-6/K/H/8/P/S

**AC CHARACTERISTICS I** (AC operating conditions unless otherwise noted)

Parameter		Symbol	-6		-K		-H		-8		-P		-S		Unit	Note
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
System Clock Cycle Time	$\overline{\text{CAS}}$ Latency = 3	tCK3	6	1000	7.5	1000	7.5	1000	8	1000	10	1000	10	1000	ns	
	$\overline{\text{CAS}}$ Latency = 2	tCK2	10		7.5		10		10		10		12		ns	
Clock High Pulse Width		tCHW	2.5	-	2.5	-	2.5	-	3	-	3	-	3	-	ns	1
Clock Low Pulse Width		tCLW	2.5	-	2.5	-	2.5	-	3	-	3	-	3	-	ns	1
Access Time From Clock	$\overline{\text{CAS}}$ Latency = 3	tAC3	-	5.4	-	5.4	-	5.4	-	6	-	6	-	6	ns	2
	$\overline{\text{CAS}}$ Latency = 2	tAC2	-	6	-	5.4	-	6	-	6	-	6	-	6	ns	
Data-Out Hold Time		tOH	2.7	-	2.7	-	2.7	-	3	-	3	-	3	-	ns	
Data-Input Setup Time		tDS	1.5	-	1.5	-	1.5	-	2	-	2	-	2	-	ns	1
Data-Input Hold Time		tDH	0.8	-	0.8	-	0.8	-	1	-	1	-	1	-	ns	1
Address Setup Time		tAS	1.5	-	1.5	-	1.5	-	2	-	2	-	2	-	ns	1
Address Hold Time		tAH	0.8	-	0.8	-	0.8	-	1	-	1	-	1	-	ns	1
CKE Setup Time		tCKS	1.5	-	1.5	-	1.5	-	2	-	2	-	2	-	ns	1
CKE Hold Time		tCKH	0.8	-	0.8	-	0.8	-	1	-	1	-	1	-	ns	1
Command Setup Time		tCS	1.5	-	1.5	-	1.5	-	2	-	2	-	2	-	ns	1
Command Hold Time		tCH	0.8	-	0.8	-	0.8	-	1	-	1	-	1	-	ns	1
CLK to Data Output in Low-Z Time		tOLZ	1	-	1	-	1	-	1	-	1	-	1	-	ns	
CLK to Data Output in High-Z Time	$\overline{\text{CAS}}$ Latency = 3	tOHZ3	2.7	5.4	2.7	5.4	2.7	5.4	3	6	3	6	3	6	ns	
	$\overline{\text{CAS}}$ Latency = 2	tOHZ2	2.7	5.4	2.7	5.4	3	6	3	6	3	6	3	6	ns	

Note :

- Assume  $t_R$  /  $t_F$  (input rise and fall time ) is 1ns  
If  $t_R$  &  $t_F > 1\text{ns}$ , then  $[(t_R+t_F)/2-1]\text{ns}$  should be added to the parameter
- Access times to be measured with input signals of 1v/ns edge rate, from 0.8v to 2.0v  
If  $t_R > 1\text{ns}$ , then  $(t_R/2-0.5)\text{ns}$  should be added to the parameter



**AC CHARACTERISTICS II**

Parameter		Symbol	-6		-K		-H		-8		-P		-S		Unit	Note
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
RAS Cycle Time	Operation	tRC	60	-	60	-	65	-	68	-	70	-	70	-	ns	
	Auto Refresh	tRRC	60	-	65	-	65	-	68	-	70	-	70	-	ns	
RAS to CAS Delay		tRCD	18	-	15	-	20	-	20	-	20	-	20	-	ns	
RAS Active Time		tRAS	42	100K	45	100K	45	100K	48	100K	50	100K	50	100K	ns	
RAS Precharge Time		tRP	18	-	15	-	20	-	20	-	20	-	20	-	ns	
RAS to RAS Bank Active Delay		tRRD	12	-	15	-	15	-	16	-	20	-	20	-	ns	
CAS to CAS Delay		tCCD	1	-	1	-	1	-	1	-	1	-	1	-	CLK	
Write Command to Data-In Delay		tWTL	0	-	0	-	0	-	0	-	0	-	0	-	CLK	
Data-In to Precharge Command		tDPL	2	-	2	-	2	-	1	-	1	-	1	-	CLK	
Data-In to Active Command		tDAL	5	-	4	-	5	-	4	-	3	-	3	-	CLK	
DQM to Data-Out Hi-Z		tDQZ	2	-	2	-	2	-	2	-	2	-	2	-	CLK	
DQM to Data-In Mask		tDQM	0	-	0	-	0	-	0	-	0	-	0	-	CLK	
MRS to New Command		tMRD	2	-	2	-	2	-	2	-	2	-	2	-	CLK	
Precharge to Data Output Hi-Z	CAS Latency = 3	tPROZ3	3	-	3	-	3	-	3	-	3	-	3	-	CLK	
	CAS Latency = 2	tPROZ2	2	-	2	-	2	-	2	-	2	-	2	-	CLK	
Power Down Exit Time		tPDE	1	-	1	-	1	-	1	-	1	-	1	-	CLK	
Self Refresh Exit Time		tSRE	1	-	1	-	1	-	1	-	1	-	1	-	CLK	1
Refresh Time		tREF	-	64	-	64	-	64	-	64	-	64	-	64	ms	

**Note :**

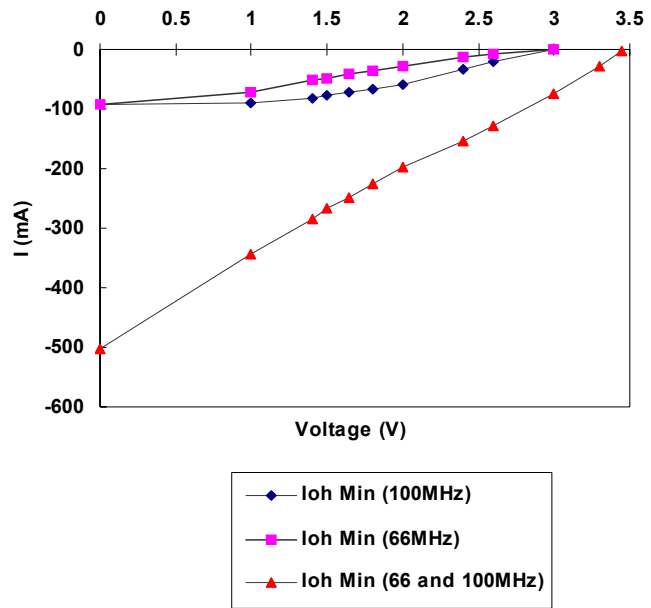
1. A new command can be given tRRC after self refresh exit.

## IBIS SPECIFICATION

### I<sub>OH</sub> Characteristics (Pull-up)

Voltage	100MHz Min	100MHz Max	66MHz Min
(V)	I (mA)	I (mA)	I (mA)
3.45		-2.4	
3.3		-27.3	
3.0	0.0	-74.1	-0.7
2.6	-21.1	-129.2	-7.5
2.4	-34.1	-153.3	-13.3
2.0	-58.7	-197.0	-27.5
1.8	-67.3	-226.2	-35.5
1.65	-73.0	-248.0	-41.1
1.5	-77.9	-269.7	-47.9
1.4	-80.8	-284.3	-52.4
1.0	-88.6	-344.5	-72.5
0.0	-93.0	-502.4	-93.0

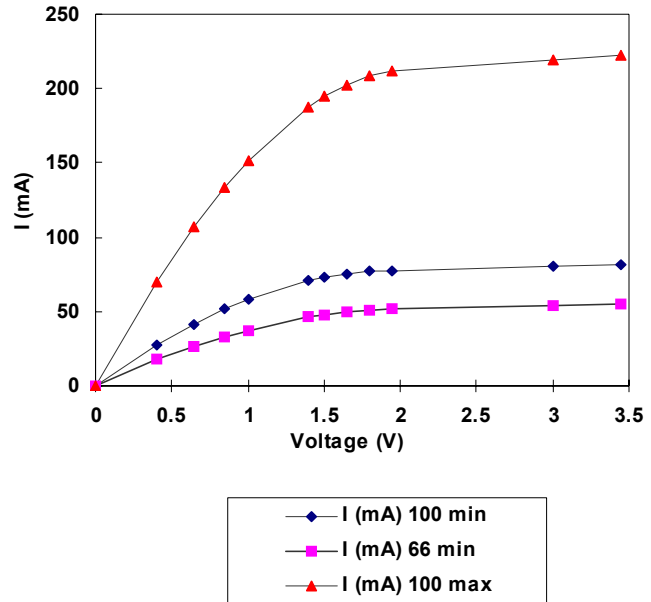
### 66MHz and 100MHz Pull-up



### I<sub>OL</sub> Characteristics (Pull-down)

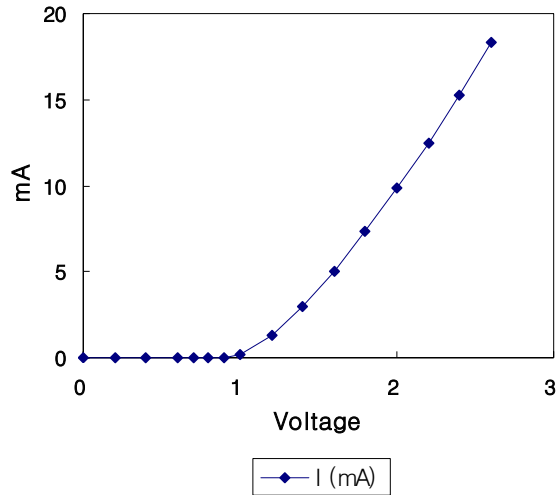
Voltage	100MHz Min	100MHz Max	66MHz Min
(V)	I (mA)	I (mA)	I (mA)
0.0	0.0	0.0	0.0
0.4	27.5	70.2	17.7
0.65	41.8	107.5	26.9
0.85	51.6	133.8	33.3
1.0	58.0	151.2	37.6
1.4	70.7	187.7	46.6
1.5	72.9	194.4	48.0
1.65	75.4	202.5	49.5
1.8	77.0	208.6	50.7
1.95	77.6	212.0	51.5
3.0	80.3	219.6	54.2
3.45	81.4	222.6	54.9

### 66MHz and 100MHz Pull-down

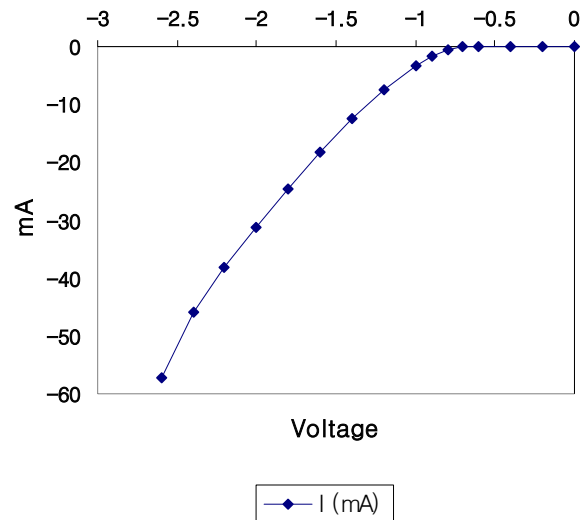


**V<sub>DD</sub> Clamp @ CLK, CKE,  $\overline{CS}$ , DQM & DQ**

V <sub>DD</sub> (V)	I(mA)
0.0	0.0
0.2	0.0
0.4	0.0
0.6	0.0
0.7	0.0
0.8	0.0
0.9	0.0
1.0	0.23
1.2	1.34
1.4	3.02
1.6	5.06
1.8	7.35
2.0	9.83
2.2	12.48
2.4	15.30
2.6	18.31

**Minimum V<sub>DD</sub> clamp current  
(Referenced to V<sub>DD</sub>)**

**V<sub>SS</sub> Clamp @ CLK, CKE,  $\overline{CS}$ , DQM & DQ**

V <sub>SS</sub> (V)	I (mA)
-2.6	-57.23
-2.4	-45.77
-2.2	-38.26
-2.0	-31.22
-1.8	-24.58
-1.6	-18.37
-1.4	-12.56
-1.2	-7.57
-1.0	-3.37
-0.9	-1.75
-0.8	-0.58
-0.7	-0.05
-0.6	0.0
-0.4	0.0
-0.2	0.0
0.0	0.0

**Minimum V<sub>SS</sub> clamp current**


**DEVICE OPERATING OPTION TABLE**
**HY57V28420HC(L)T-6**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
166MHz(6ns)	3CLKs	3CLKs	7CLKs	10CLKs	3CLKs	5.4ns	2.7ns
143MHz(7ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	5.4ns	2.7ns
133MHz(7.5ns)	2CLKs	3CLKs	6CLKs	9CLKs	3CLKs	5.4ns	2.7ns

**HY57V28420HC(L)T-K**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
133MHz(7.5ns)	2CLKs	2CLKs	6CLKs	8CLKs	2CLKs	5.4ns	2.7ns
125MHz(8ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	6ns	3ns
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns

**HY57V28420HC(L)T-H**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
133MHz(7.5ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	5.4ns	2.7ns
125MHz(8ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	6ns	3ns
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns

**HY57V28420A(L)T-8**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
125MHz(8ns)	3CLKs	3CLKs	6CLKs	9CLKs	3CLKs	6ns	3ns
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns
83MHz(12ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	3ns

**HY57V28420HC(L)T-P**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
100MHz(10ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns
83MHz(12ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns
66MHz(15ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	3ns

**HY57V28420HC(L)T-S**

	CAS Latency	tRCD	tRAS	tRC	tRP	tAC	tOH
100MHz(10ns)	3CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns
83MHz(12ns)	2CLKs	2CLKs	5CLKs	7CLKs	2CLKs	6ns	3ns
66MHz(15ns)	2CLKs	2CLKs	4CLKs	6CLKs	2CLKs	6ns	3ns

**COMMAND TRUTH TABLE**

Command	CKEn-1	CKEn	$\overline{\text{CS}}$	$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WE}}$	DQM	ADDR	A10/ AP	BA	Note
Mode Register Set	H	X	L	L	L	L	X	OP code			1
No Operation	H	X	H	X	X	X	X	X			
			L	H	H	H					
Bank Active	H	X	L	L	H	H	X	RA		V	
Read	H	X	L	H	L	H	X	CA	L	V	
Read with Autoprecharge									H		
Write	H	X	L	H	L	L	X	CA	L	V	
Write with Autoprecharge									H		
Precharge All Banks	H	X	L	L	H	L	X	X	H	X	
Precharge selected Bank									L	V	
Burst Stop	H	X	L	H	H	L	X	X			
DQM	H	X					V	X			
Auto Refresh	H	H	L	L	L	H	X	X			
Burst-Read-Single-WRITE	H	X	L	L	L	L	X	A9 Pin High (Other Pins OP code)			3
Self Refresh	Entry	H	L	L	L	L	H	X	X		
	Exit	L	H	H	X	X	X	X			
Precharge power down	Entry	H	L	H	X	X	X	X	X		
				L	H	H	H				
	Exit	L	H	H	X	X	X	X			
				L	H	H	H				
Clock Suspend	Entry	H	L	H	X	X	X	X	X		
				L	V	V	V				
	Exit	L	H	X			X				

**Note :**

- Exiting Self Refresh occurs by asynchronously bringing CKE from low to high
- X = Dont care, H = Logic High, L= Logic Low, BA=Bank Address, RA = Row Address, CA = Column Address, Opcode=Operand Code, NOP=No Operation
- The burst read sigle write mode is entered by programming the write burst mode bit (A9) in the mode register to a logic 1.

## PACKAGE INFORMATION

### 400mil 54pin Thin Small Outline Package

Unit : mm(inch)

